

**Search Notes**

Application/Control No.

10/799,596

Examiner

Emily Y. Chan

Applicant(s)/Patent under  
Reexamination

YANO ET AL.

Art Unit

2829

**SEARCHED**

Class	Subclass	Date	Examiner
324	770	10/24/2005	EC
SEARCH	UPDATED	10/24/2005	EC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
US PG PUB searched (see History print out)		10/24/2005	EC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventorship and Plus searched	8/16/2005	EC
324/767,770 and G09G/3/32 IPC (text searched -only see search history printout)	8/16/2005	EC
324/767,765,158.1 (text search only- see search history printout)	10/24/2005	EC
Consulted with primary examiner Mr. VINH P. NGUYEN.	10/24/2005	EC